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## FDC3535

**April 2015** 

# P-Channel Power Trench $^{\circledR}$ MOSFET -80 V, -2.1 A, 183 m $\Omega$

## **Features**

- Max  $r_{DS(on)}$  = 183 m $\Omega$  at  $V_{GS}$  = -10 V,  $I_D$  = -2.1 A
- $\blacksquare$  Max  $\rm r_{DS(on)}$  = 233 m $\Omega$  at  $\rm V_{GS}$  = -4.5 V,  $\rm I_D$  = -1.9 A
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- High power and current handling capability in a widely used surface mount package
- Fast switching speed
- 100% UIL Tested
- RoHS Compliant

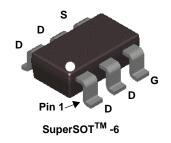


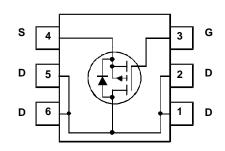
## **General Description**

This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been optimized for  $r_{DS(on)}$ , switching performance and ruggedness.

## **Applications**

- Load Switch
- Synchronous Rectifier





## MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage		-80	V
V <sub>GS</sub>	Gate to Source Voltage		±20	V
I <sub>D</sub>	Drain Current -Continuous	(Note 1a)	-2.1	^
	-Pulsed		-10	A
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	37	mJ
P <sub>D</sub>	Power Dissipation	(Note 1a)	1.6	W
	Power Dissipation	(Note 1b)	0.7	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	30	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	78	C/VV

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
.535	FDC3535	SSOT-6	7 "	8 mm	3000 units

## **Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted

**Parameter** 

Off Characteristics							
$BV_DSS$	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-80			V	
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25 °C		-64		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -64 V, V <sub>GS</sub> = 0 V			-1	μА	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA	

**Test Conditions** 

Min

Тур

Max

Units

#### **On Characteristics**

Symbol

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1	-1.6	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25 °C		5		mV/°C
		$V_{GS} = -10 \text{ V}, I_D = -2.1 \text{ A}$		147	183	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -1.9 \text{ A}$		176	233	mΩ
		$V_{GS} = -10 \text{ V}, I_D = -2.1 \text{ A}, T_J = 125 \text{ °C}$		246	307	1
9 <sub>FS</sub>	Forward Transconductance	$V_{DD} = -10 \text{ V}, I_D = -2.1 \text{ A}$		6.3		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = 0 V, f = 1 MHz	659	880	pF
Coss	Output Capacitance		49	65	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		24	40	pF
$R_q$	Gate Resistance		5.7		Ω

## **Switching Characteristics**

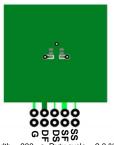
t <sub>d(on)</sub>	Turn-On Delay Time		6.5	13	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = -40 V, I <sub>D</sub> = -2.1 A,	3.1	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = -10 V, $R_{GEN}$ = 6 $\Omega$	23	38	ns
t <sub>f</sub>	Fall Time		2.9	10	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to -10 V	14	20	nC
	Total Gate Charge	$V_{GS} = 0 \text{ V to } -4.5 \text{ V}$ $V_{DD} = -40 \text{ V}$	6.8	10	nC
$Q_{gs}$	Total Gate Charge	I <sub>D</sub> = -2.1 A	1.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		2.7		nC

## **Drain-Source Diode Characteristics**

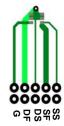
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A}$ (Note 2	)	-0.81	-1.3	V
t <sub>rr</sub>	Reverse Recovery Time	$I_{E} = -2.1 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$		25	40	ns
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>F</sub> = -2.1 A, α//αt = 100 A/μS		23	38	nC

#### NOTES:

1.  $R_{BJA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{BJC}$  is guaranteed by design while  $R_{BCA}$  is determined by the user's board design.



a. 78 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b.175 °C/W when mounted on a minimum pad of 2 oz copper

- G D G G S 2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.
- 3. Starting T  $_J$  = 25  $^{o}C,\,L$  = 3 mH, I  $_{AS}$  = -5 A, V  $_{DD}$  = -80 V, V  $_{GS}$  = -10 V.

## Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

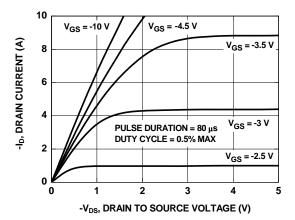


Figure 1. On-Region Characteristics

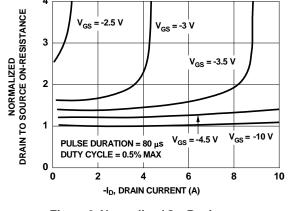


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

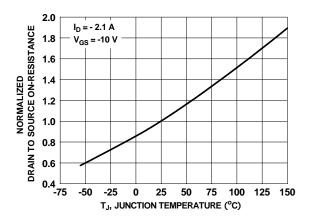


Figure 3. Normalized On-Resistance vs Junction Temperature

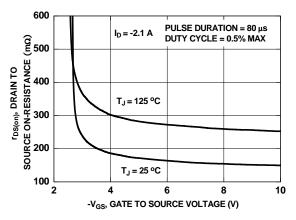


Figure 4. On-Resistance vs Gate to Source Voltage

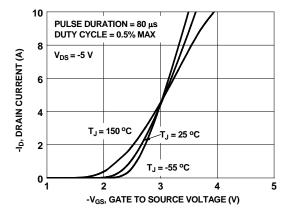


Figure 5. Transfer Characteristics

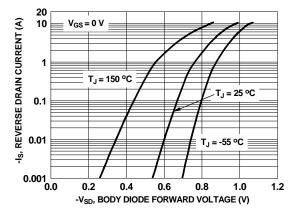


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

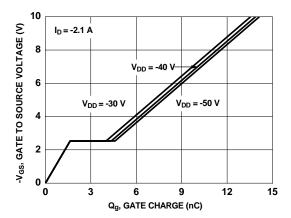


Figure 7. Gate Charge Characteristics

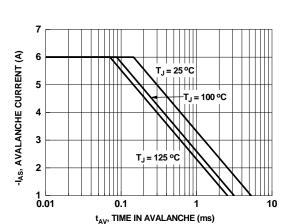
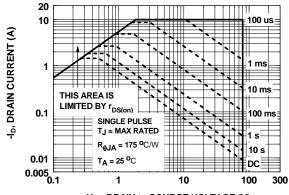


Figure 9. Unclamped Inductive Switching Capability



-V<sub>DS</sub>, DRAIN to SOURCE VOLTAGE (V)
Figure 11. Forward Bias Safe
Operating Area

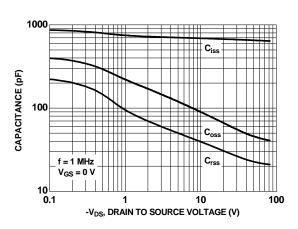


Figure 8. Capacitance vs Drain to Source Voltage

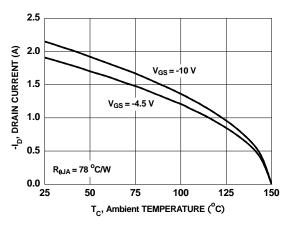


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

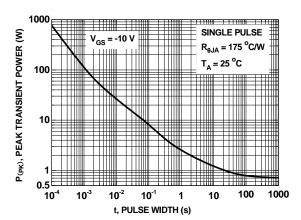


Figure 12. Single Pulse Maximum Power Dissipation



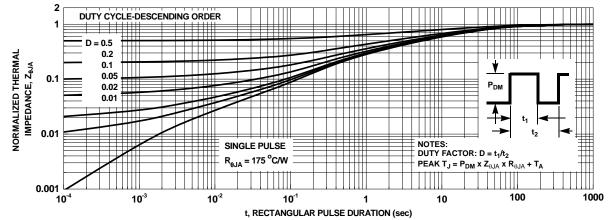
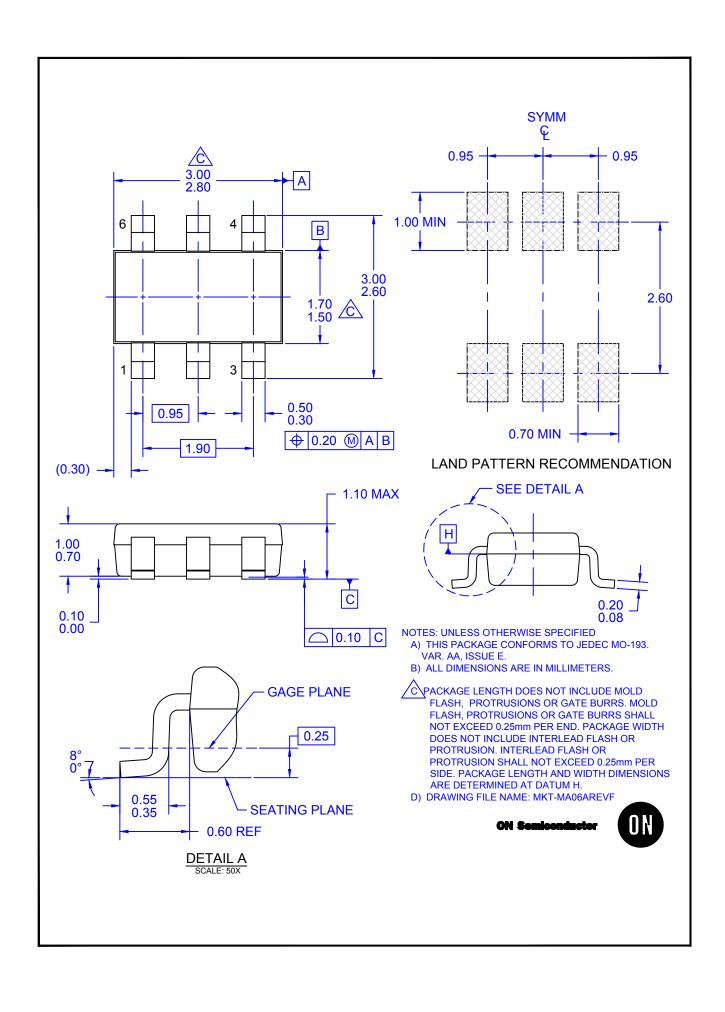


Figure 13. Junction-to-Ambient Transient Thermal Response Curve



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